

<b>Notice of References Cited</b>	Application/Control No. 10/560,225		Applicant(s)/Patent Under Reexamination AOTA ET AL.	
	Examiner Lynne Edmondson		Art Unit 1725	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0102354	06-2003	Okamura et al.	228/112.1
*	B	US-2006/0086775	04-2006	Trapp et al.	228/112.1
*	C	US-2005/0145678	07-2005	Murakami, Kotoyoshi	228/112.1
*	D	US-6,843,405	01-2005	Okamoto et al.	228/112.1
*	E	US-2002/0092885	07-2002	Ezumi et al.	228/2.1
*	F	US-6,936,332	08-2005	Aota et al.	428/156
*	G	US-2005/0242158	11-2005	Bolser, David R.	228/112.1
*	H	US-6,325,273	12-2001	Boon et al.	228/112.1
*	I	US-2003/0111514	06-2003	Miyanagi et al.	228/112.1
*	J	US-6,045,028	04-2000	Martin et al.	228/112.1
*	K	US-2001/0038028	11-2001	Iwashita, Tomoyuki	228/112.1
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	GB 2306366 A	05-1997	United Kingdom	THOMAS et al.	
*	O	JP 2001314982 A	11-2001	Japan	KANO et al.	
	P	JP 10230376 A	09-1998	Japan	MICHISAKA, KOUZOU	
*	Q	EP 1498210 A1	01-2005	European Patent	NISHIGUCHI et al.	
	R	JP 2002066760 A	03-2002	Japan	NOMURA et al.	
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.